

May 2014

FDMS7602S

Dual N-Channel PowerTrench[®] MOSFET Q1: 30 V, 30 A, 7.5 m Ω Q2: 30 V, 30 A, 5.0 m Ω

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 7.5 m Ω at V_{GS} = 10 V, I_D = 12 A
- Max $r_{DS(on)} = 12 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 10 \text{ A}$

Q2: N-Channel

- Max $r_{DS(on)} = 5.0 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 17 \text{ A}$
- Max $r_{DS(on)} = 6.8 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 14 \text{ A}$
- RoHS Compliant

General Description

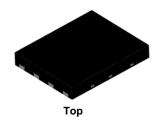
This device includes two specialized N-Channel MOSFETs in a dual MLP package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFETTM (Q2) have been designed to provide optimal power efficiency.

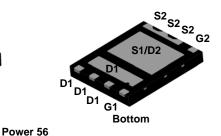
Applications

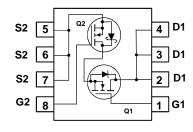
- Computing
- Communications
- General Purpose Point of Load



■ Notebook VCORE







MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter	Q1	Q2	Units	
V _{DS}	Drain to Source Voltage		30	30	V
V_{GS}	Gate to Source Voltage	Gate to Source Voltage (Note 3)		±20	V
	Drain Current -Continuous	T _C = 25 °C	30	30	
I _D	-Continuous	T _A = 25 °C	12 ^{1a}	17 ^{1b}	Α
	-Pulsed		40	60	
Б	Power Dissipation for Single Operation	T _A = 25 °C	2.2 ^{1a}	2.5 ^{1b}	W
P_{D}	Power Dissipation for Single Operation	T _A = 25 °C	1.0 ^{1c}	1.0 ^{1d}	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range -55 to +150				°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	57 ^{1a}	50 ^{1b}	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	125 ^{1c}	120 ^{1d}	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.5	2	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7602S	FDMS7602S	Power 56	13 "	12 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Тур	Max	Units
Off Chara	cteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$ $I_D = 1 mA, V_{GS} = 0 V$	Q1 Q2	30 30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C I_D = 1 mA, referenced to 25 °C	Q1 Q2		15 15		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V	Q1 Q2			1 500	μ Α μ Α
I _{GSS}	Gate to Source Leakage Current	V _{GS} = 20 V, V _{DS} = 0 V V _{GS} = 20 V, V _{DS} = 0 V	Q1 Q2			100 100	nA nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = 1 mA$	Q1 Q2	1 1	1.8 1.8	3	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C I_D = 1 mA, referenced to 25 °C	Q1 Q2		-6 -5		mV/°C	
	r _{DS(on)} Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, \ I_D = 12 \text{ A}$ $V_{GS} = 4.5 \text{ V}, \ I_D = 10 \text{ A}$ $V_{GS} = 10 \text{ V}, \ I_D = 12 \text{ A}, \ T_J = 125 ^{\circ}\text{C}$	Q1		6.0 8.5 8.3	7.5 12 12		
DS(on)		$V_{GS} = 10 \text{ V}, \ I_D = 17 \text{ A}$ $V_{GS} = 4.5 \text{ V}, \ I_D = 14 \text{ A}$ $V_{GS} = 10 \text{ V}, \ I_D = 17 \text{ A}, \ T_J = 125 ^{\circ}\text{C}$	Q2		4.2 5.4 4.9	5.0 6.8 7.2	mΩ	
g _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 12 \text{ A}$ $V_{DS} = 5 \text{ V}, I_{D} = 17 \text{ A}$	Q1 Q2		63 87		S	

Dynamic Characteristics

C _{iss}	Input Capacitance	Q1: V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2	1315 2020	1750 2690	pF
C _{oss}	Output Capacitance	Q2:	Q1 Q2	445 860	600 1145	pF
C _{rss}	Reverse Transfer Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHZ}$	Q1 Q2	45 95	70 145	pF
R _g	Gate Resistance		Q1 Q2	0.9 0.7		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			Q1 Q2	8.6 11	18 20	ns
t _r	Rise Time	Q1: V _{DD} = 15 V, I _D = 12 A,	, R _{GEN} = 6 Ω	Q1 Q2	2.5 3.8	10 10	ns
t _{d(off)}	Turn-Off Delay Time	Q2: $V_{DD} = 15 \text{ V}, I_{D} = 17 \text{ A}, R_{GEN} = 6 \Omega$		Q1 Q2	20 27	32 43	ns
t _f	Fall Time			Q1 Q2	2.3 3.2	10 10	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V Q		Q1 Q2	20 33	28 46	nC
Q_g	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 15 \text{ V},$ $I_{D} = 12 \text{ A}$		Q1 Q2	9.3 16	13 22	nC
Q _{gs}	Gate to Source Gate Charge	Q: Vr	2 _{DD} = 15 V,	Q1 Q2	4.3 5.8		nC
Q_{gd}	Gate to Drain "Miller" Charge	$I_{D} = 13 \text{ V},$ $I_{D} = 17 \text{ A}$		Q1 Q2	2.2 4.6		nC

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Drain-Sou	Prain-Source Diode Characteristics						
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 12 \text{ A}$ (Note 2) $V_{GS} = 0 \text{ V}, I_S = 17 \text{ A}$ (Note 2)			0.8 0.8	1.2 1.2	V
t _{rr}	Reverse Recovery Time	Q1 I _F = 12 A, di/dt = 100 A/μs	Q1 Q2		27 29	43 46	ns
Q _{rr}	Reverse Recovery Charge	Q2 $I_F = 17 \text{ A, di/dt} = 300 \text{ A/}\mu\text{s}$	Q1 Q2		10 31	18 50	nC

Notes:1: $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



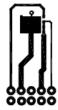
a. 57 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 50 °C/W when mounted on a 1 in² pad of 2 oz copper



c. 125 °C/W when mounted on a minimum pad of 2 oz copper



d. 120 °C/W when mounted on a minimum pad of 2 oz copper

- 2: Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3: As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.

Typical Characteristics (Q1 N-Channel)T_J = 25°C unless otherwise noted

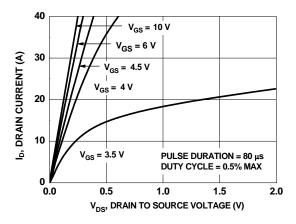


Figure 1. On Region Characteristics

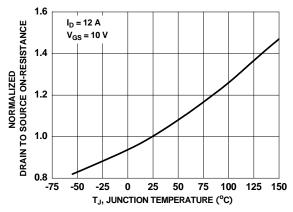


Figure 3. Normalized On Resistance vs Junction Temperature

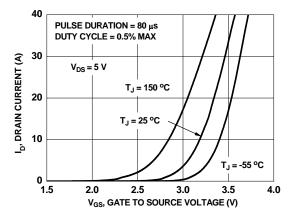


Figure 5. Transfer Characteristics

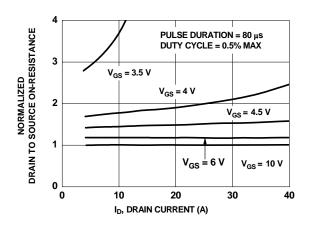


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

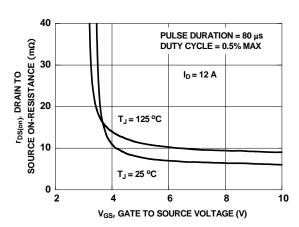


Figure 4. On-Resistance vs Gate to Source Voltage

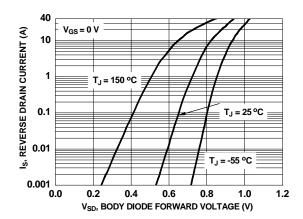


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q1 N-Channel)T_J = 25°C unless otherwise noted

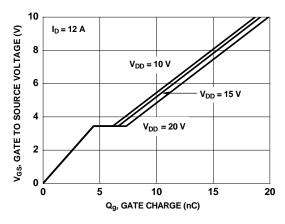


Figure 7. Gate Charge Characteristics

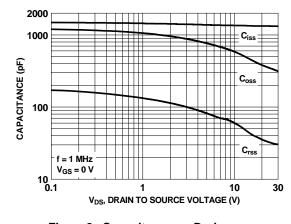


Figure 8. Capacitance vs Drain to Source Voltage

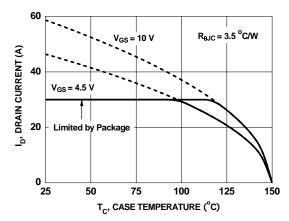


Figure 9. Maximum Continuous Drain Current vs Case Temperature

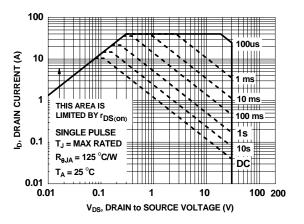


Figure 10. Forward Bias Safe Operating Area

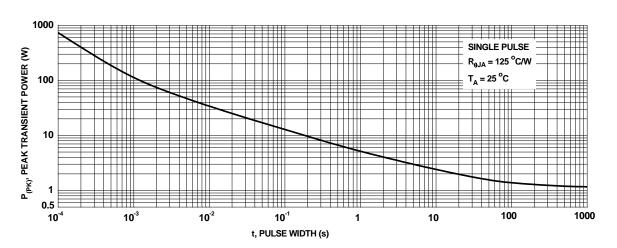


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q1 N-Channel)T_J = 25°C unless otherwise noted

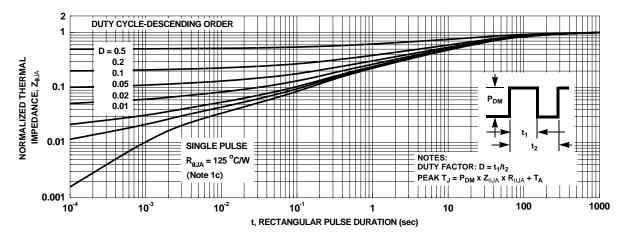


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (Q2 SyncFET)

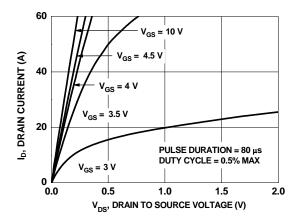


Figure 13. On-Region Characteristics

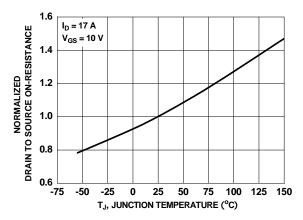


Figure 15. Normalized On-Resistance vs Junction Temperature

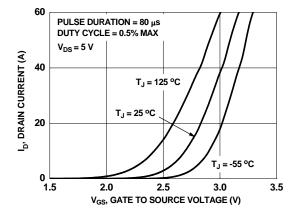


Figure 17. Transfer Characteristics

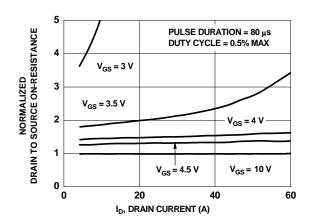


Figure 14. Normalized on-Resistance vs Drain Current and Gate Voltage

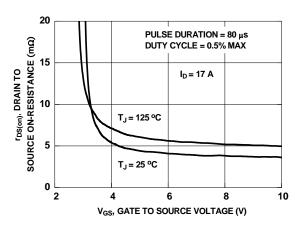


Figure 16. On-Resistance vs Gate to Source Voltage

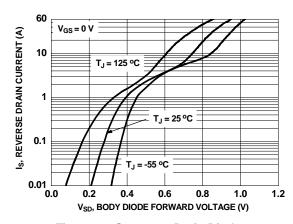


Figure 18. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q2 SyncFET)

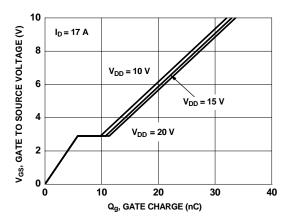


Figure 19. Gate Charge Characteristics

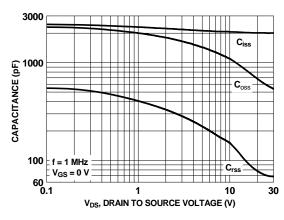


Figure 20. Capacitance vs Drain to Source Voltage

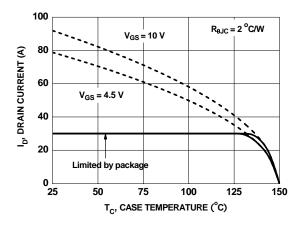


Figure 21. Maximum Continuous Drain Current vs Case Temperature

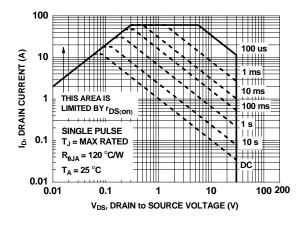


Figure 22. Forward Bias Safe Operating Area

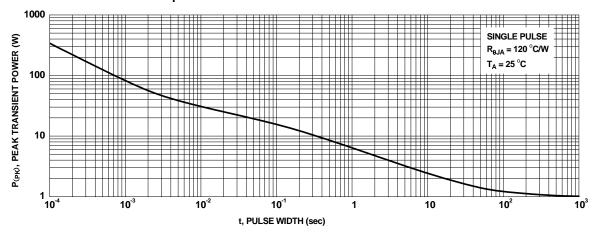


Figure 23. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q2 SyncFET)

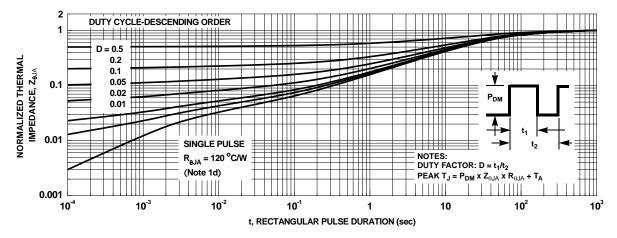


Figure 24. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (continued)

SyncFETTM Schottky body diode Characteristics

Fairchild's SyncFETTM process embeds a Schottky diode in parallel with PowerTrench[®] MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 25 shows the reverse recovery characteristic of the FDMS7602S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

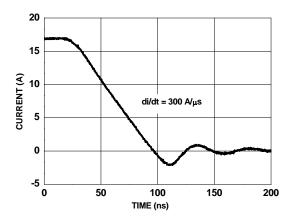


Figure 25. FDMS7602S SyncFETTM Body Diode Reverse Recovery Characteristic

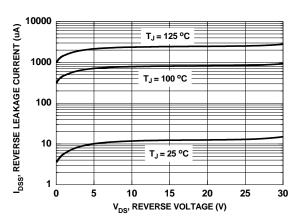
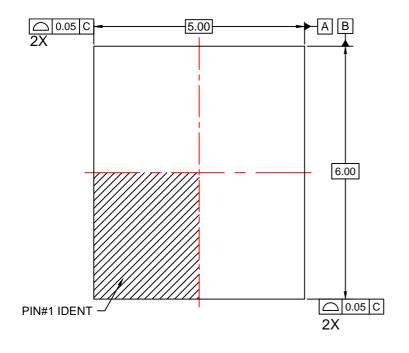
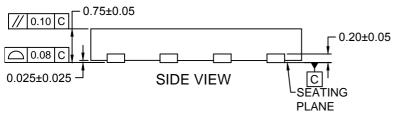
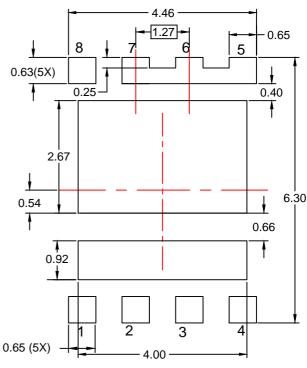


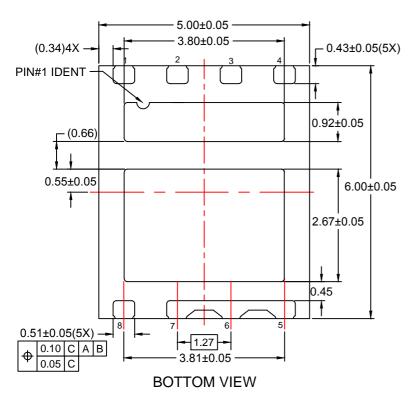
Figure 26. SyncFETTM Body Diode Reverse Leakage vs. Drain-Source Voltage





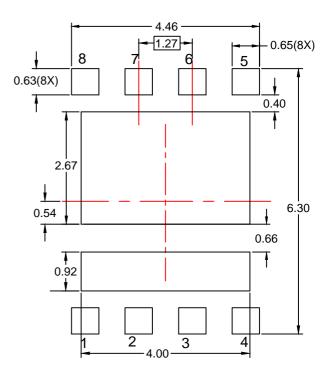


RECOMMENDED LAND PATTERN (OPTION 1 - FUSED LEADS 5,6,7)



NOTES:

- A. PACKAGE DOES NOT FULLY CONFORM TO JEDEC STANDARD.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-MLP08Prev2.



RECOMMENDED LAND PATTERN (OPTION 2 - ISOLATED LEADS)







TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

 $\begin{array}{lll} {\sf AccuPower^{TM}} & & {\sf F-PFS^{TM}} \\ {\sf Awinda}^{\otimes} & {\sf FRFET}^{\otimes} \\ {\sf AX-CAP}^{\otimes*} & & {\sf Global\ Power\ Resource}^{\sf SM} \end{array}$

BitSiC™ GreenBridge™
Build it Now™ Green FPS™

CorePLUS™ Green FPS™ e-Series™

Current Transfer Logic™ ISOPLANAR™

DEUXPEED® Making Small Speakers Sound Louder

 Dual Cool™
 and Better™

 EcoSPARK®
 MegaBuck™

 EfficientMax™
 MICROCOUPLER™

ESBC™

MicroFET™

MicroPak™

MicroPak™

MicroPak2™

Fairchild®

Fairchild Semiconductor®

FACT Quiet Series™

MotionMax™

MotionGrid®

MotionGrid®

PowerTrench[®] PowerXS™

Programmable Active Droop™

QFET[®] QS™

> Quiet Series™ RapidConfigure™

Saving our world, 1mW/W/kW at a time™

SignalWise™ SmartMax™ SMART START™

Solutions for Your Success™

SPM®
STEALTH™
SuperFET®
SuperSOT™-3
SuperSOT™-6
SuperSOT™-8
SupreMOS®
SyncFET™
Sync-Lock™

SYSTEM SERVERAL®*

TinyBoost®
TinyBuck®
TinyCalc™
TinyLogic®
TINYOPTO™
TinyPower™
TinyPWM™
TinyWire™
TranSiC™
TriFault Detect

TriFault Detect™
TRUECURRENT®*
µSerDes™

SerDes"
UHC®
Ultra FRFET™
UniFET™
VCX™
VisualMax™
VoltagePlus™
XST™
XSEMS™
从童™

* Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. TO OBTAIN THE LATEST, MOST UP-TO-DATE DATASHEET AND PRODUCT INFORMATION, VISIT OUR WEBSITE AT http://www.fairchildsemi.com. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which, (a) are
 intended for surgical implant into the body or (b) support or sustain
 life, and (c) whose failure to perform when properly used in
 accordance with instructions for use provided in the labeling, can be
 reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Definition of Terms	Definition of Terms						
Datasheet Identification Product Sta		Definition					
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.					
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.					
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.					
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.					

Rev. 171